

CSD18532KCS 60V N-Channel NexFET™ Power MOSFET

1 Features

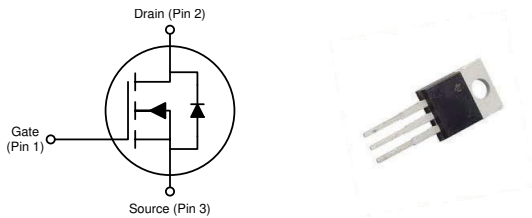
- Ultra-low Q_g and Q_{gd}
- Low thermal resistance
- Avalanche rated
- Logic level
- Pb free terminal plating
- RoHS compliant
- Halogen free
- TO-220 plastic package

2 Applications

- DC-DC conversion
- Secondary side synchronous rectifier
- Motor control

Description

This 60V, 3.3m Ω , TO-220 NexFET™ power MOSFET is designed to minimize losses in power conversion applications.



Product Summary

$T_A = 25^\circ\text{C}$		TYPICAL VALUE		UNIT
V_{DS}	Drain-to-Source Voltage	60		V
Q_g	Gate Charge Total (10V)	44		nC
Q_{gd}	Gate Charge Gate-to-Drain	6.9		nC
$R_{DS(on)}$	Drain-to-Source On Resistance	$V_{GS} = 4.5\text{V}$	4.2	m Ω
		$V_{GS} = 10\text{V}$	3.3	m Ω
$V_{GS(th)}$	Threshold Voltage	1.8		V

Ordering Information⁽¹⁾

Device	Package	Media	Qty	Ship
CSD18532KCS	TO-220 Plastic Package	Tube	50	Tube

- (1) For all available packages, see the orderable addendum at the end of the data sheet.

Absolute Maximum Ratings

$T_A = 25^\circ\text{C}$		VALUE	UNIT
V_{DS}	Drain-to-Source Voltage	60	V
V_{GS}	Gate-to-Source Voltage	± 20	V
I_D	Continuous Drain Current (Package limited), $T_C = 25^\circ\text{C}$	100	A
	Continuous Drain Current (Silicon limited), $T_C = 25^\circ\text{C}$	169	
	Continuous Drain Current (Silicon limited), $T_C = 100^\circ\text{C}$	116	
I_{DM}	Pulsed Drain Current ⁽¹⁾	400	A
P_D	Power Dissipation	250	W
T_J , T_{stg}	Operating Junction and Storage Temperature Range	-55 to 175	$^\circ\text{C}$
E_{AS}	Avalanche Energy, single pulse $I_D = 75\text{A}$, $L = 0.1\text{mH}$, $R_G = 25\Omega$	281	mJ

- (1) Pulse duration $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$

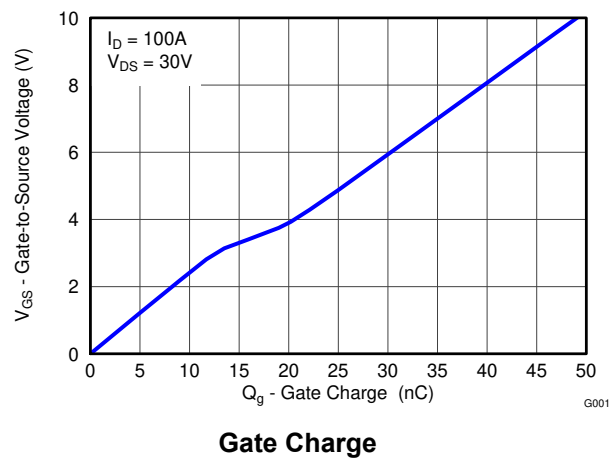
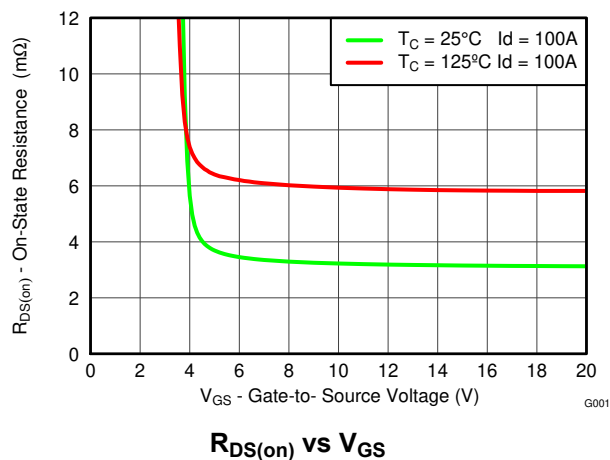


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3 Specifications

3.1 Electrical Characteristics

(T_A = 25°C unless otherwise stated)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT	
STATIC CHARACTERISTICS							
BV _{DSS}	Drain-to-Source Voltage	V _{GS} = 0V, I _D = 250μA	60			V	
I _{DSS}	Drain-to-Source Leakage Current	V _{GS} = 0V, V _{DS} = 48V	1			μA	
I _{GSS}	Gate-to-Source Leakage Current	V _{DS} = 0V, V _{GS} = 20V	100			nA	
V _{GS(th)}	Gate-to-Source Threshold Voltage	V _{DS} = V _{GS} , I _D = 250μA	1.5	1.8	2.2	V	
R _{DS(on)}	Drain-to-Source On Resistance	V _{GS} = 4.5V, I _D = 100A	4.2			5.3	mΩ
		V _{GS} = 10V, I _D = 100A	3.3			4.2	mΩ
g _{fs}	Transconductance	V _{DS} = 30V, I _D = 100A	187			S	
DYNAMIC CHARACTERISTICS							
C _{iss}	Input Capacitance	V _{GS} = 0V, V _{DS} = 30V, f = 1MHz	3900			4680	pF
C _{oss}	Output Capacitance		470			564	pF
C _{rss}	Reverse Transfer Capacitance		11			14	pF
R _G	Series Gate Resistance		1.3			2.6	Ω
Q _g	Gate Charge Total (4.5V)	V _{DS} = 30V, I _D = 100A	21			25	nC
Q _g	Gate Charge Total (10V)		44			53	nC
Q _{gd}	Gate Charge Gate-to-Drain		6.9				nC
Q _{gs}	Gate Charge Gate-to-Source		10				nC
Q _{g(th)}	Gate Charge at V _{th}		7.3				nC
Q _{oss}	Output Charge	V _{DS} = 30V, V _{GS} = 0V	52				nC
t _{d(on)}	Turn On Delay Time	V _{DS} = 30V, V _{GS} = 10V, I _{DS} = 100A, R _G = 0Ω	7.8				ns
t _r	Rise Time		5.3				ns
t _{d(off)}	Turn Off Delay Time		24.2				ns
t _f	Fall Time		5.6				ns
DIODE CHARACTERISTICS							
V _{SD}	Diode Forward Voltage	I _{SD} = 100A, V _{GS} = 0V	0.8			1	V
Q _{rr}	Reverse Recovery Charge	V _{DS} = 30V, I _F = 100A, di/dt = 300A/μs	127				nC
t _{rr}	Reverse Recovery Time		57				ns

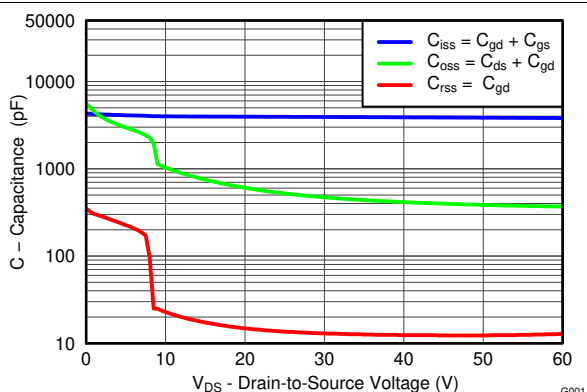
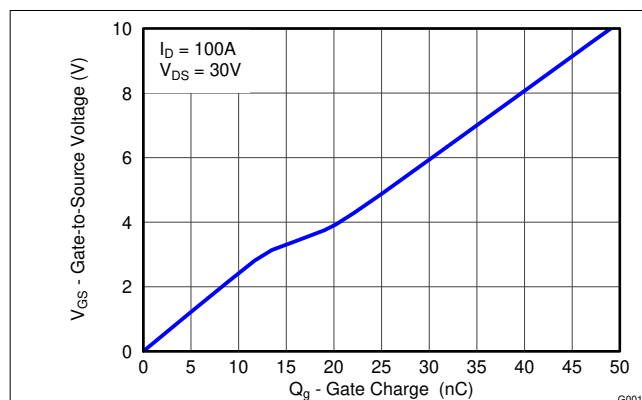
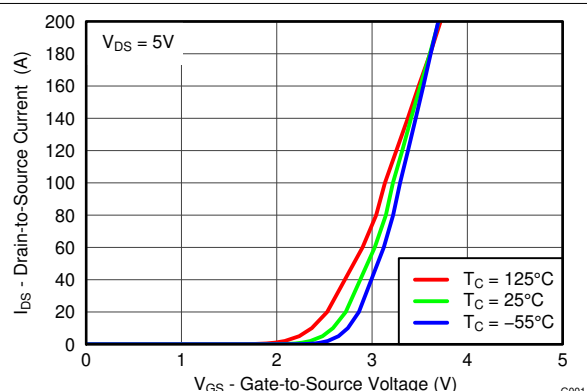
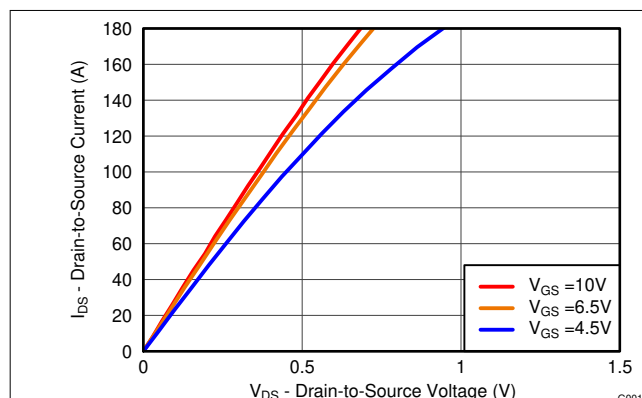
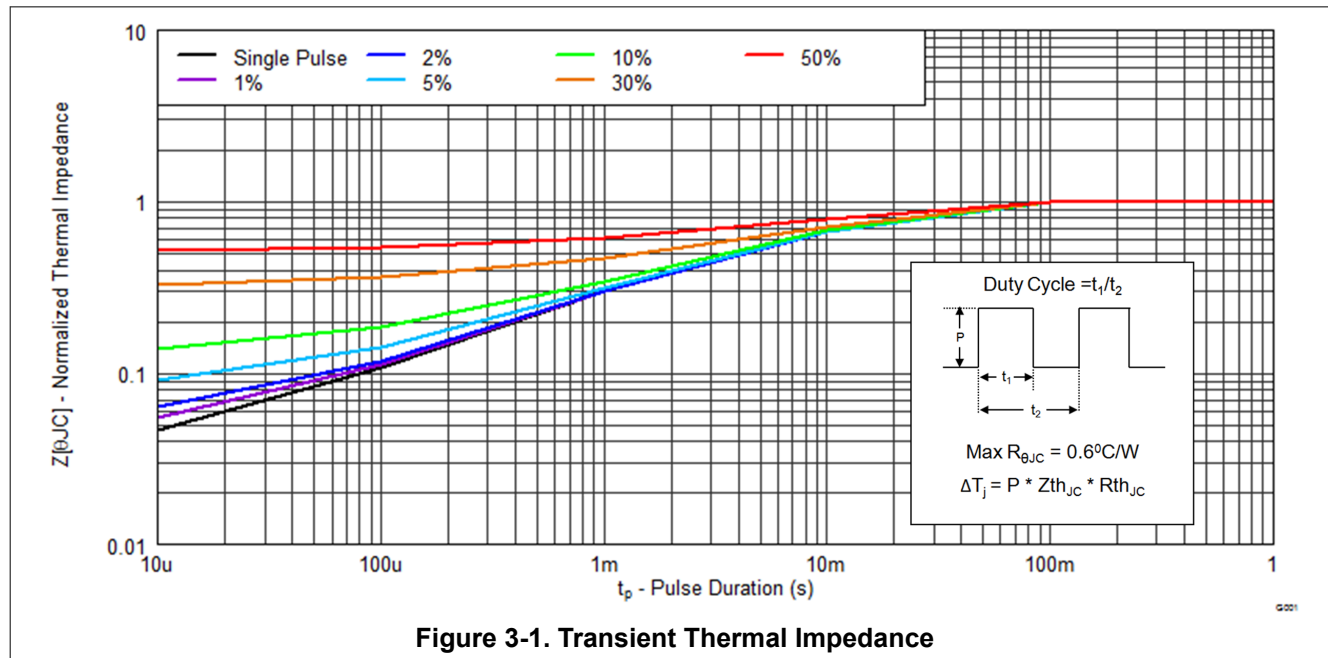
3.2 Thermal Information

(T_A = 25°C unless otherwise stated)

THERMAL METRIC		MIN	TYP	MAX	UNIT
R _{θJC}	Junction-to-Case Thermal Resistance			0.6	°C/W
R _{θJA}	Junction-to-Ambient Thermal Resistance			62	

3.3 Typical MOSFET Characteristics

($T_A = 25^\circ\text{C}$ unless otherwise stated)



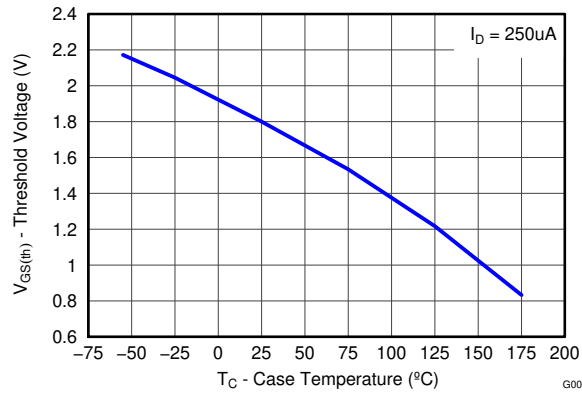


Figure 3-6. Threshold Voltage vs Temperature

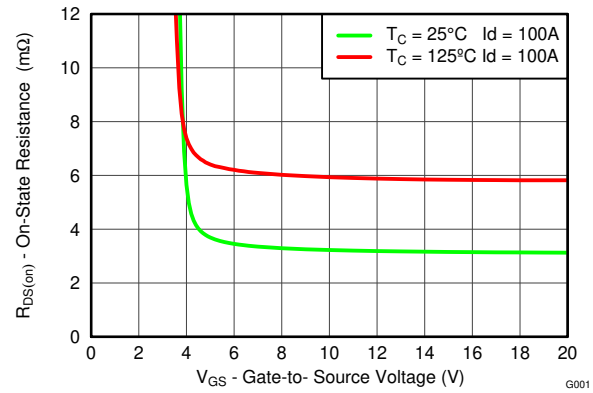


Figure 3-7. On-State Resistance vs Gate-to-Source Voltage

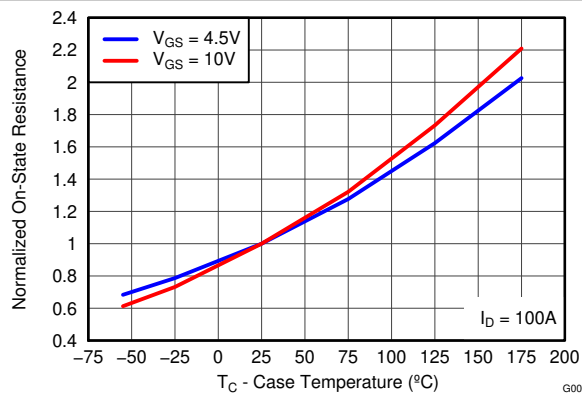


Figure 3-8. Normalized On-State Resistance vs Temperature

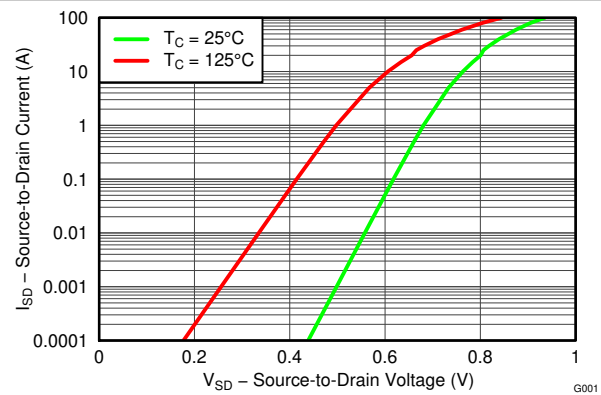


Figure 3-9. Typical Diode Forward Voltage

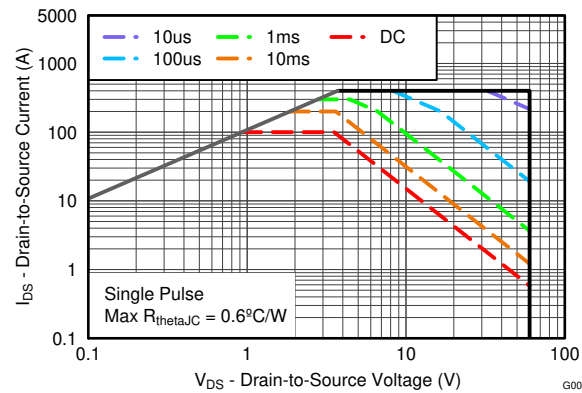


Figure 3-10. Maximum Safe Operating Area

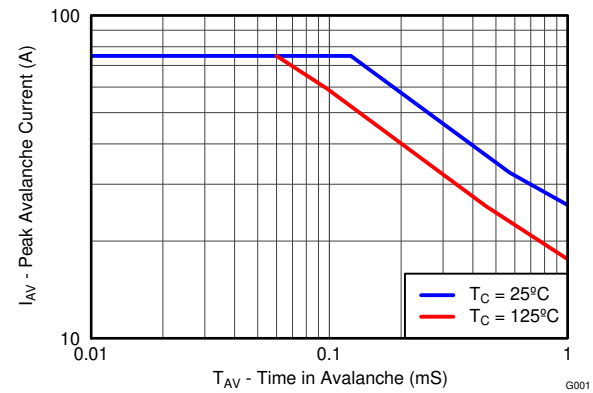


Figure 3-11. Single Pulse Unclamped Inductive Switching

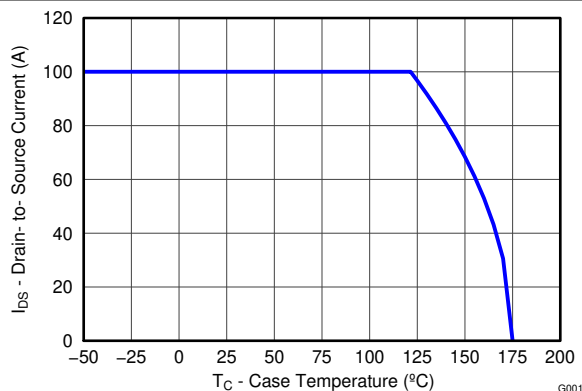


Figure 3-12. Maximum Drain Current vs Temperature

4 Device and Documentation Support

4.1 Third-Party Products Disclaimer

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4.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

4.3 Support Resources

[TI E2E™ support forums](#) are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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4.4 Trademarks

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4.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

4.6 Glossary

[TI Glossary](#) This glossary lists and explains terms, acronyms, and definitions.

5 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

Changes from Revision B (August 2012) to Revision C (March 2024) Page

- Updated the numbering format for tables, figures, and cross-references throughout the document..... 1

Changes from Revision A (October 2012) to Revision B (July 2014) Page

- Increased I_D at $T_C = 100^\circ\text{C}$ to 116A..... 1
- Increased I_{DM} to 400A 1
- Increased max operating junction and storage temperature to 175°C 1
- Updated [Figure 3-1](#) from a normalized $R_{\theta JA}$ to an $R_{\theta JC}$ curve..... 4
- Updated [Figure 3-6](#) to extend to 175°C 4
- Updated [Figure 3-8](#) to extend to 175°C 4
- Updated the SOA in [Figure 3-10](#) 4
- Updated [Figure 3-12](#) to extend to 175°C 4

Changes from Revision * (August 2012) to Revision A (October 2012)	Page
• Changed the Transconductance TYP value From: 146S To: 187S.....	3
• Changed $R_{\theta JA}$ From: MAX = 62°C/W To: MAX = 65°C/W.....	3
• Changed Figure 3-2	4

6 Mechanical Data

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package Pins	Package qty Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
CSD18532KCS	Active	Production	TO-220 (KCS) 3	50 TUBE	ROHS Exempt	SN	N/A for Pkg Type	-55 to 175	CSD18532KCS
CSD18532KCS.B	Active	Production	TO-220 (KCS) 3	50 TUBE	ROHS Exempt	SN	N/A for Pkg Type	-55 to 175	CSD18532KCS

- (1) **Status:** For more details on status, see our [product life cycle](#).
- (2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.
- (3) **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.
- (4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.
- (5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.
- (6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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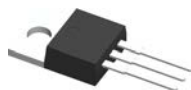
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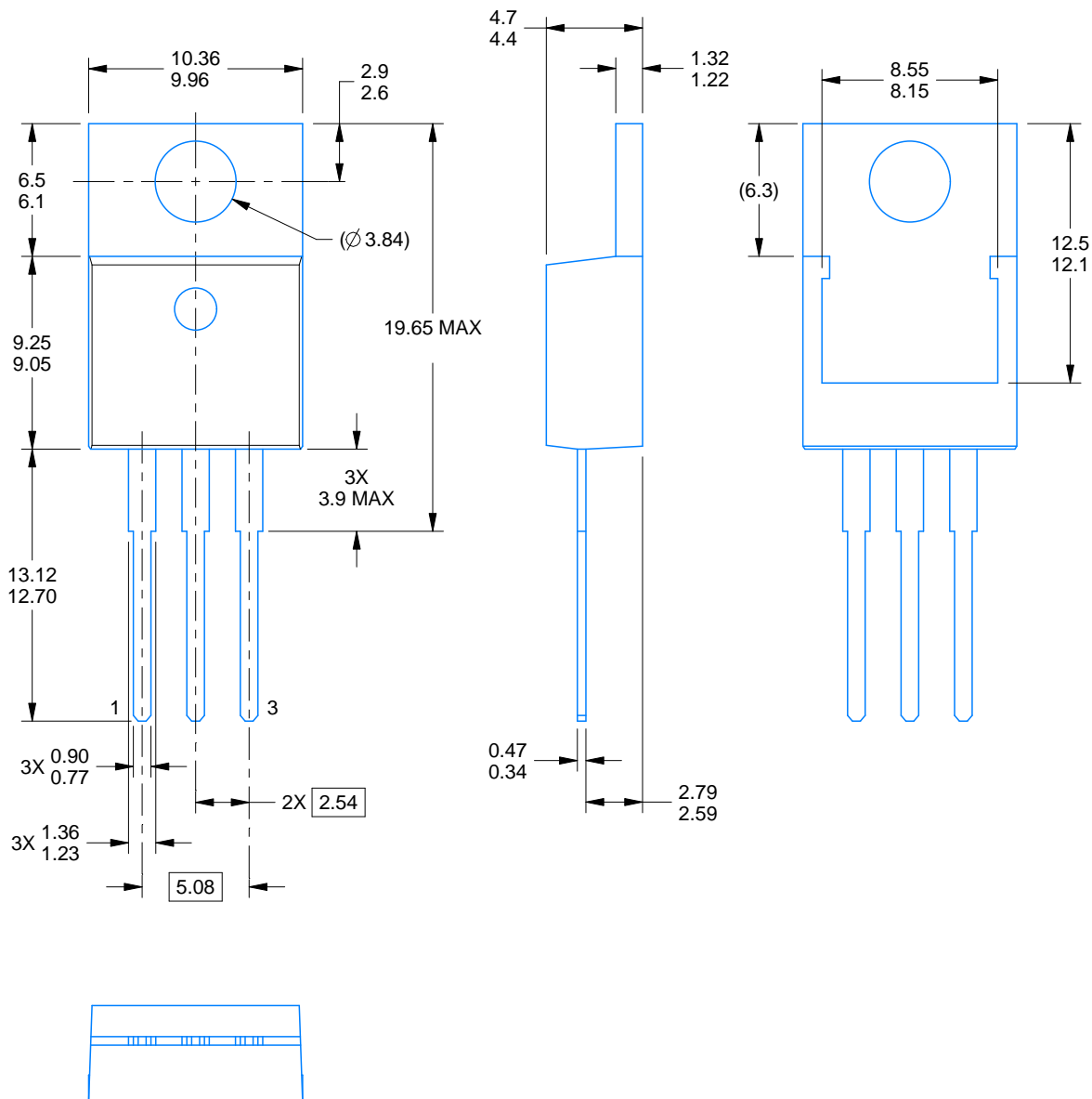


*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (μm)	B (mm)
CSD18532KCS	KCS	TO-220	3	50	532	34.1	700	9.6
CSD18532KCS	KCS	TO-220	3	50	532	34.1	700	9.6
CSD18532KCS.B	KCS	TO-220	3	50	532	34.1	700	9.6
CSD18532KCS.B	KCS	TO-220	3	50	532	34.1	700	9.6

KCS0003B**PACKAGE OUTLINE****TO-220 - 19.65 mm max height**

TO-220



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NOTES:

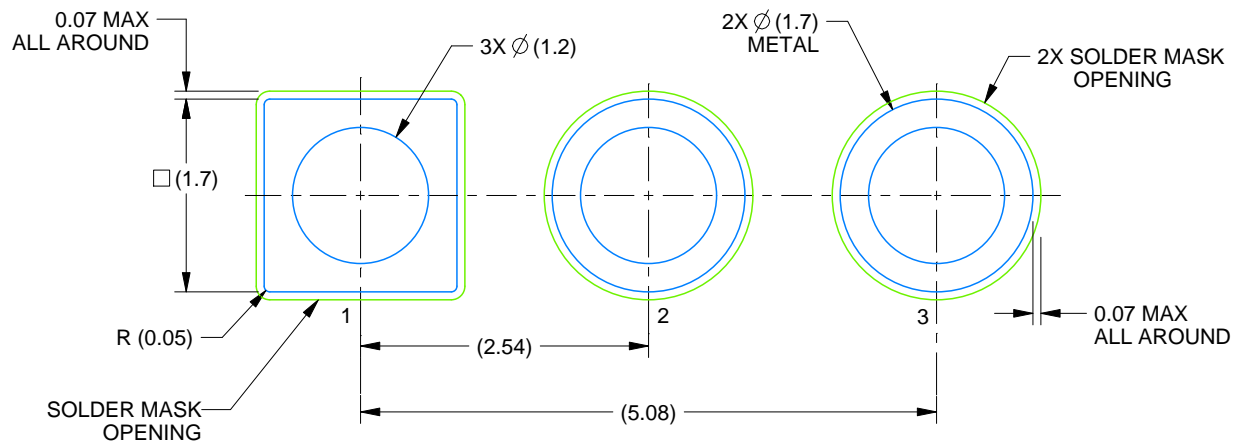
1. Dimensions are in millimeters. Any dimension in brackets or parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. Reference JEDEC registration TO-220.

EXAMPLE BOARD LAYOUT

KCS0003B

TO-220 - 19.65 mm max height

TO-220



LAND PATTERN EXAMPLE
NON-SOLDER MASK DEFINED
SCALE:15X

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